

**Search Notes**

Application/Control No.

10/665,264

Examiner

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Applicant(s)/Patent under  
Reexamination

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Art Unit

2651

**SEARCHED**

Class	Subclass	Date	Examiner
360	65,48-49	3/24/2005	NFM
360	53,46	3/24/2005	NFM
360	67,57	3/24/2005	NFM
360	77.08	3/24/2005	NFM
360	78.14	3/24/2005	NFM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	3/23/2005	NFM
NPL Search (IEEE Database)	3/23/2005	NFM
NPL Search (JPO Database)	3/23/2005	NFM
Kin Wong	3/23/2005	NFM